Features

- **No External Components Except PIN Diode**
- **Supply-voltage Range: 4.5V to 5.5V**
- **Automatic Sensitivity Adaptation (AGC)**
- **Automatic Strong Signal Adaptation (ATC)**
- **Enhanced Immunity Against Ambient Light Disturbances**
- **Available for Carrier Frequencies between 33 kHz to 40 kHz; Adjusted by Zener Diode Fusing**
- **TTL and CMOS Compatible**
- **Suitable Minimum Burst Length ≥ 10 Pulses/Burst**

Applications

- **Audio Video Applications**
- **Home Appliances**
- **Remote Control Equipment**

1. Description

The IC ATA2525 is a complete IR receiver for data communication that was developed and optimized for use in carrier-frequency-modulated transmission applications. Its function can be described using the block diagram (see Figure 1-1 on page 2). The input stage meets two main functions. First, it provides a suitable bias voltage for the PIN diode. Secondly, the pulsed photo-current signals are transformed into a voltage by a special circuit which is optimized for low-noise applications. After amplification by a **C**ontrolled **G**ain **A**mplifier (CGA), the signals have to pass a tuned integrated narrow bandpass filter with a center frequency f_0 which is equivalent to the chosen carrier frequency of the input signal. The demodulator is used to convert the input burst signal into a digital envelope output pulse and to evaluate the signal information quality, i.e., unwanted pulses will be suppressed at the output pin. All this is done by means of an integrated dynamic feedback circuit which varies the gain as a function of the present environmental condition (ambient light, modulated lamps etc.). Other special features are used to adapt to the current application to secure best transmission quality. The ATA2525 operates in a supply-voltage range of 4.5V to 5.5V.

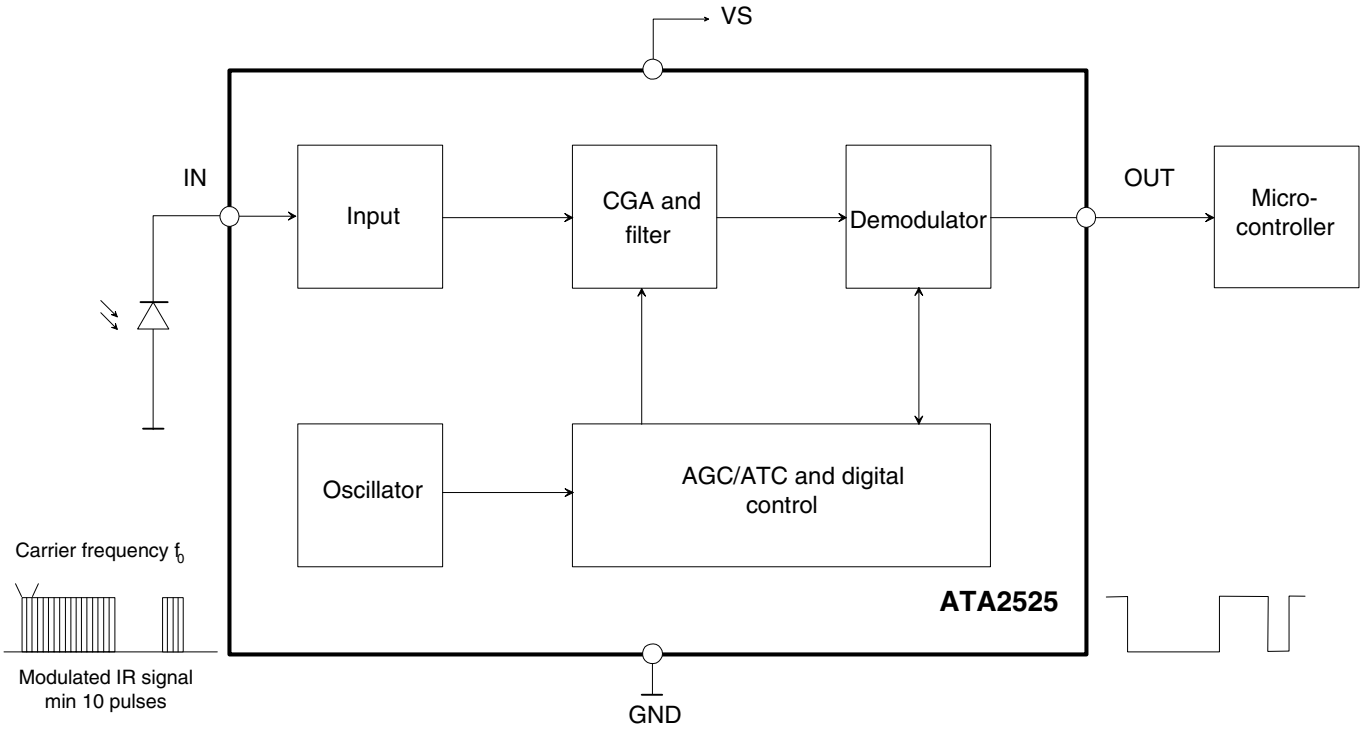
IR Receiver ASSP

ATA2525

Preliminary

Rev. 4854B–AUTO–05/05

Figure 1-1. Block Diagram



2. Pin Configuration

Figure 2-1. Pinning TSSOP8

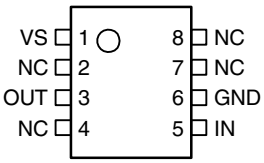


Table 2-1. Pin Description

Pin	Symbol	Function
1	VS	Supply voltage
2	NC	Not connected
3	OUT	Data output
4	NC	Not connected
5	IN	Input PIN diode
6	GND	Ground
7	NC	Not connected
8	NC	Not connected

3. Absolute Maximum Ratings

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Parameters	Symbol	Value	Unit
Supply voltage	V_S	–0.3 to +6	V
Supply current	I_S	3	mA
Input voltage	V_{IN}	–0.3 to V_S	V
Input DC current at V_S = 5V	I_{IN}	0.75	mA
Output voltage	V_O	–0.3 to V_S	V
Output current	I_O	10	mA
Operating temperature	T_{amb}	–25 to +85	°C
Storage temperature	T_{stg}	–40 to +125	°C
Power dissipation at T_{amb} = 25°C	P_{tot}	30	mW

4. Thermal Resistance

Parameter	Symbol	Value	Unit
Junction ambient TSSOP8	R_{thJA}	110	K/W

5. Electrical Characteristics

T_{amb} = –25°C to +85°C, V_S = 4.5V to 5.5V unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Typ.	Max.	Unit	Type*
1	**Supply**								
1.1	Supply-voltage range		1	V_S	4.5	5	5.5	V	C
1.2	Supply current	I_{IN} = 0	1	I_S	0.8	1.1	1.4	mA	B
2	**Output**								
2.1	Internal pull-up resistor	T_{amb} = 25°C; see Figure 8-7 on page 8	1,3	R_{PU}		40		kΩ	A
2.2	Output voltage low	I_L = 2 mA; see Figure 8-7 on page 8	3,6	V_{OL}			250	mV	B
2.3	Output voltage high		3,1	V_{OH}	V_S – 0.25		V_S	V	B
2.4	Output current clamping	R_2 = 0; see Figure 8-7 on page 8	3,6	I_{OCL}		8		mA	B
3	**Input**								
3.1	Input DC current	V_{IN} = 0; see Figure 8-7 on page 8	5	I_{IN_DCMAX}	–85			µA	C
3.2	Input DC current; Figure 8-1 on page 5	V_{IN} = 0; V_s = 5V, T_{amb} = 25°C	5	I_{IN_DCMAX}	–530	–960		µA	B

*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Notes: 1. BER = Bit Error Rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT

2. After transformation of input current into voltage

5. Electrical Characteristics (Continued)

T_{amb} = –25°C to +85°C, V_S = 4.5V to 5.5V unless otherwise specified.

No.	Parameters	Test Conditions	Pin	Symbol	Min.	Typ.	Max.	Unit	Type*
3.3	Minimum detection threshold current; Figure 8-2 on page 5	Test signal: see Figure 8-6 on page 7 V_S = 5V, T_{amb} = 25°C, I_{IN_DC} = 1 µA; square pp, burst N = 16, f = f_0; t_{PER} = 10 ms, Figure 8-6 on page 7; BER = 50(1)	3	I_{Eemin}		–520		pA	B
3.4	Minimum detection threshold current with AC current disturbance IIN_AC100 = 3 µA at 100 Hz	Test signal: see Figure 8-6 on page 7 V_S = 5V, T_{amb} = 25°C, I_{IN_DC} = 1 µA, square pp, burst N = 16, f = f_0; t_{PER} = 10 ms, Figure 8-6 on page 7; BER = 50%(1)	3	I_{Eemin}		–800		pA	C
3.5	Maximum detection threshold current with V_{IN} > 0V	Test signal: see Figure 8-6 on page 7 V_S = 5V, T_{amb} = 25°C, I_{IN_DC} = 1 µA; square pp, burst N = 16, f = f_0; t_{PER} = 10 ms, Figure 8-6 on page 7; BER = 5%(1)	3	I_{Eemax}	–400			µA	D
4	**Controlled Amplifier and Filter**								
4.1	Maximum value of variable gain (CGA)			G_{VARMAX}		51		dB	D
4.2	Minimum value of variable gain (CGA)			G_{VARMIN}		–5		dB	D
4.3	Total internal amplification(2)			G_{MAX}		71		dB	D
4.4	Center frequency fusing accuracy of bandpass	V_S = 5V, T_{amb} = 25°C		f_{0_FUSE}	–3	f_0	+3	%	A
4.5	Overall accuracy center frequency of bandpass			f_0	–6.7	f_0	+4.1	%	C
4.6	BPF bandwidth	–3 dB; f_0 = 38 kHz; see Figure 8-4 on page 6		B		3.5		kHz	B

*) Type means: A =100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Notes: 1. BER = Bit Error Rate; e.g., BER = 5% means that with P = 20 at the input pin 19...21 pulses can appear at the pin OUT

2. After transformation of input current into voltage

6. ESD

All pins ⇒ 4000V HBM; 400V MM, MIL-STD-883C, Method 3015.7

LU 100 mA; Jedec 17/78

7. Reliability

Electrical qualification (1000h at 150°C) in molded SO8 plastic package

8. Typical Electrical Curves at T_{amb} = 25°C

Figure 8-1. V_{IN} versus I_{IN_DC}, V_S = 5V

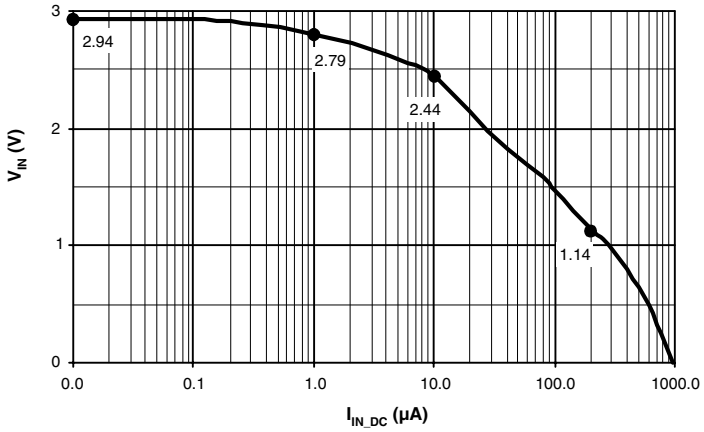


Figure 8-2. I_{Eemin} versus I_{IN_DC}, V_S = 5V

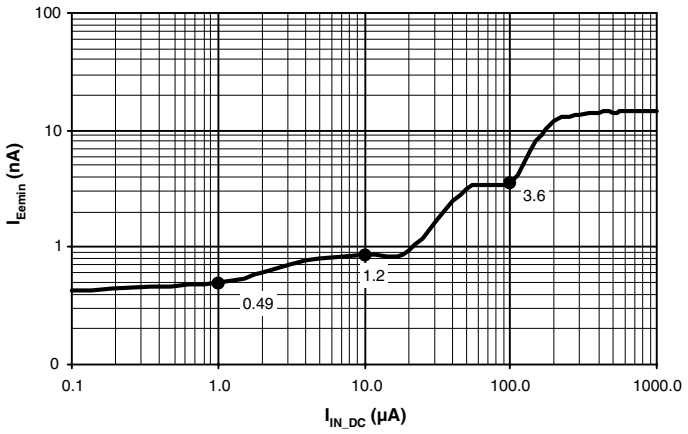


Figure 8-3. Data Transmission Rate, V_S = 5V

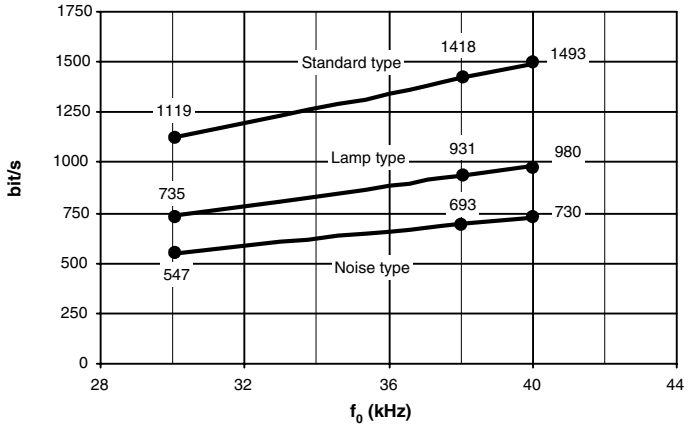
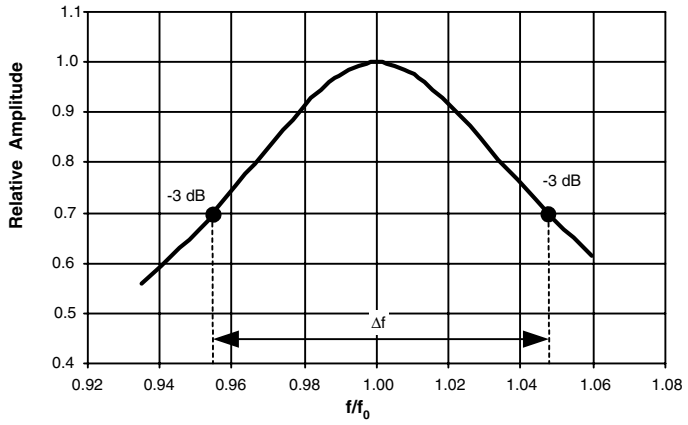
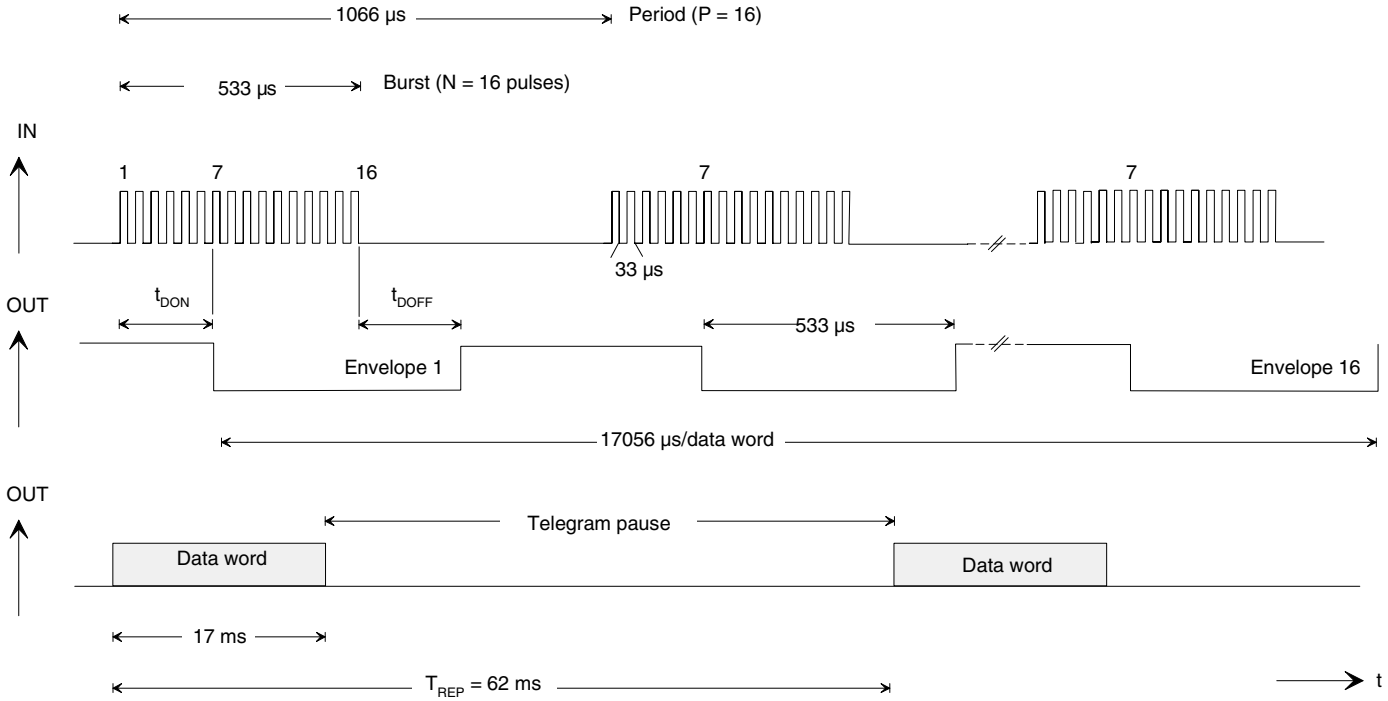


Figure 8-4. Typical Bandpass Curve



$Q = f_0/\Delta f$; Δf = –3 dB values. Example: Q = 1/(1.047 – 0.954) = 11

Figure 8-5. Illustration of Used Terms



Example: f = 30 kHz, burst with 16 pulses, 16 periods

Figure 8-6. Test Circuit

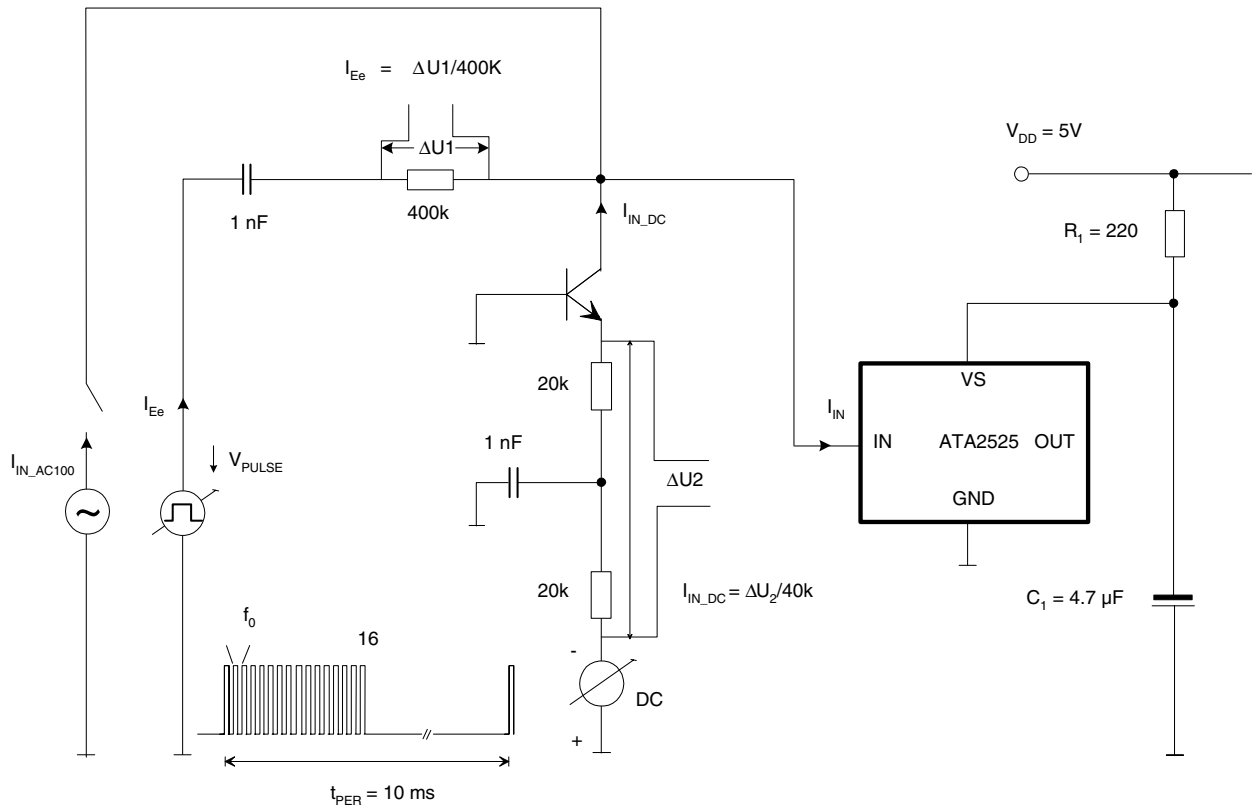
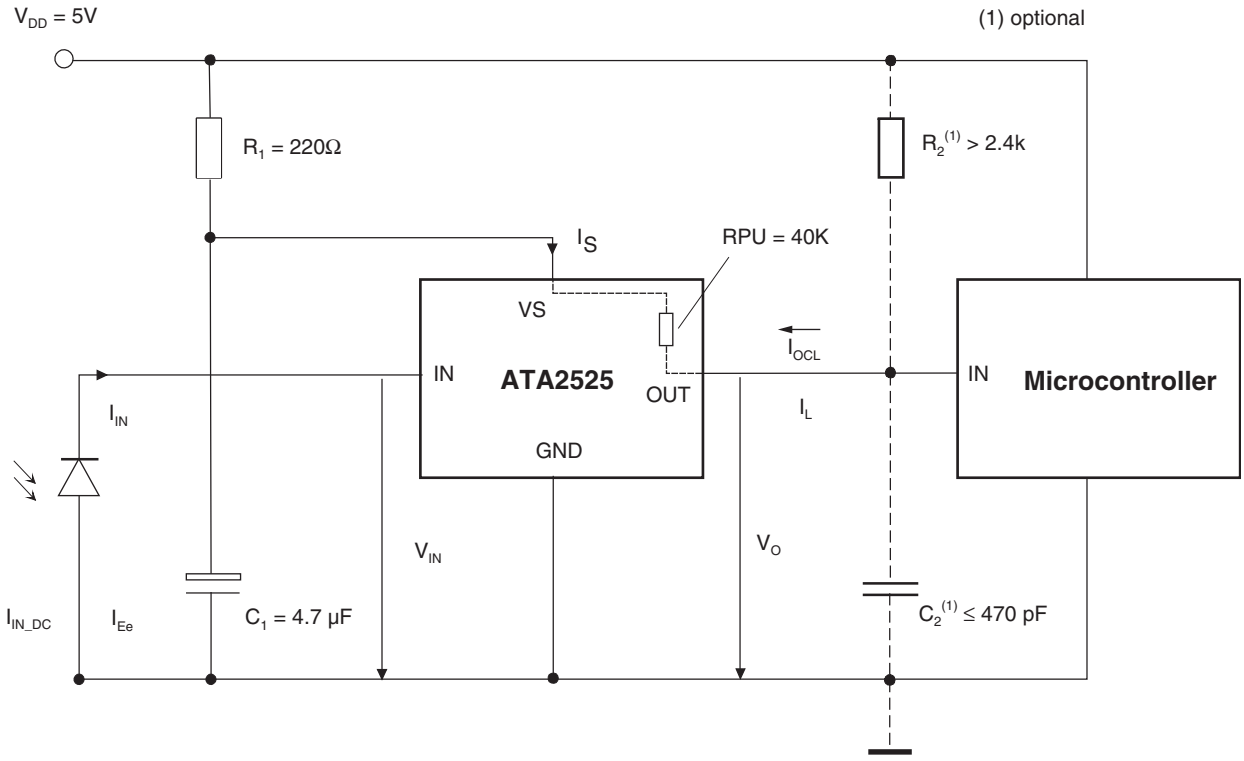
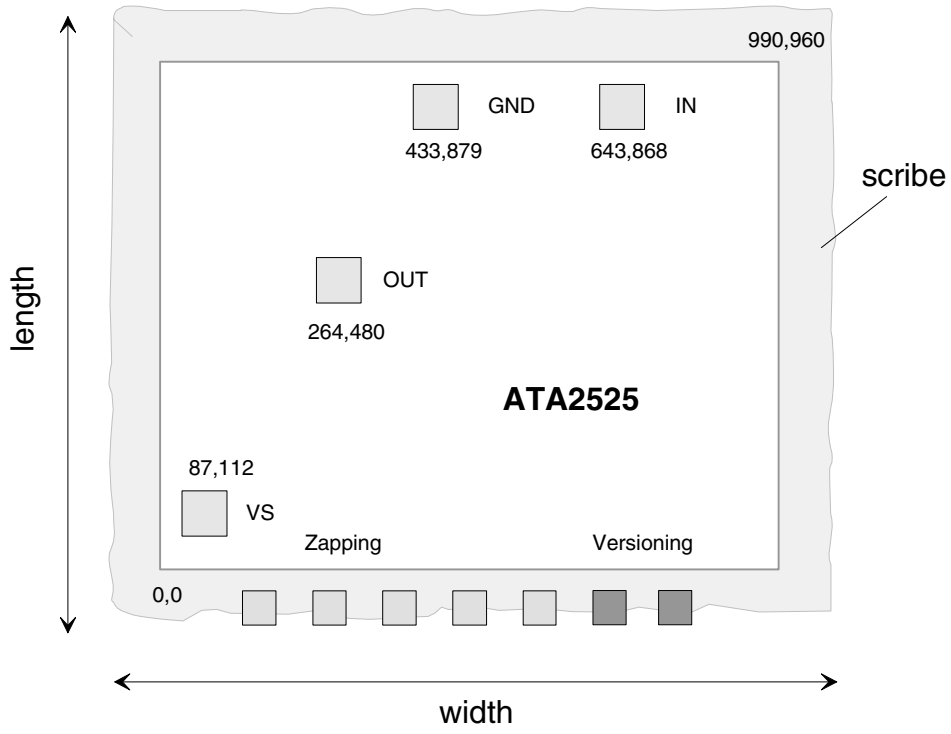


Figure 8-7. Application Circuit



9. Chip Dimensions

Figure 9-1. Chip Size in µm



Note: Pad coordinates are for lower left corner of the pad in µm from the origin 0,0

Dimensions	Length inclusive scribe	1.04 mm
	Width inclusive scribe	1.11 mm
	Thickness	290 µ ±5%
	Pads	80 µ × 80 µ
	Fusing pads	60 µ × 60 µ
Pad metallurgy	Material	AlCu/AlSiTi(1)
	Thickness	0.8 µm
Finish	Material	Si_3N_4/SiO_2(1)
	Thickness	0.7/0.3 µm

Note: 1. Value depends on manufacture location.

10. Ordering Information

Extended Type Number	D[3]	Type
ATA2525P1.xx[1]-yyy[2]	1493	**Standard type:** high data rate
ATA2525P3.xx[1]-yyy[2]	980	**Lamp type:** enhanced suppression of disturbances, secure data transmission
ATA2525P5.xx[1]-yyy[2]	730	**Noise type:** best suppression of disturbances, low data rate

Notes: 1. xx means the used carrier frequency value (33, 36, 38 or 40 kHz)

2. yyy means kind of packaging:
   DDW --> unsawn wafers in box
   6AQ --> (only on request, TSSOP8 taped and reeled)
3. Maximum data transmission rate up to bits/s with f_0 = 40 kHz, V_S = 5V (see Figure 8-2 on page 5)

11. Pad Layout

Figure 11-1. Pad Layout (DDW or TSSOP8)

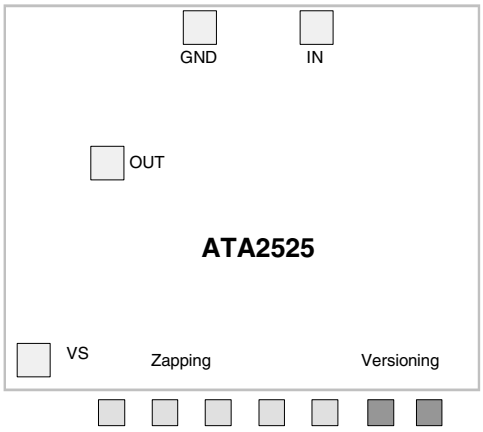


Table 11-1. Pin Description

Symbol	Function
OUT	Data output
VS	Supply voltage
GND	GND
IN	Input pin diode
Zapping	f_0 adjust
Versioning	type adjust

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